## Application/Control No. Applicant(s)/Patent Under Reexamination 10/601,252 LEE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Pierre-Michel Bataille 2186 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2005/0071542 03-2005 Α Weber et al. 711/105 \* В US-6,031,241 02-2000 Silfvast et al. 250/504R US-С D US-US-Ε F US-G US-US-Н USı US-Κ US-US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.